

1.Features

- $V_{DS(V)} = -30V$
- $R_{DS(ON)} < 75m\Omega (V_{GS} = -10V)$
- $R_{DS(ON)} < 110m\Omega (V_{GS} = -4.5V)$

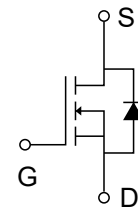
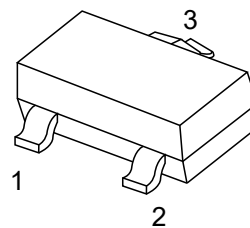
2.Applications

- Load Switch
- Optimized for Battery and Load Management
Applications in Portable Equipment like Cell Phones, PDA's, Media Players, etc

3.Pinning information

Pin	Symbol	Description
1	G	GATE
2	S	SOURCE
3	D	DRAIN

SOT-23



4.Maximum ratings ($T_A = 25^\circ C$ unless otherwise noted)

Parameter			Symbol	Value	Units
Drain - to - Source Voltage			V_{DSS}	-30	V
Drain - to - Source Voltage			V_{GS}	± 12	
Continuous Drain Current (Note 1)	Steady State $t \leq 5\text{ s}$	$T_A = 25^\circ C$	I_D	-2.2	A
		$T_A = 85^\circ C$		-1.5	
		$T_A = 25^\circ C$		-3.5	
Power Dissipation (Note 1)	Steady State $t \leq 5\text{ s}$	$T_A = 25^\circ C$	P_D	0.48	W
				1.25	
Pulsed Drain Current	$t_p = 10\mu s$		I_{DM}	-15	A
Operating Junction and Storage Temperature			T_J, T_{STG}	-55 to 150	$^\circ C$
Source Current (Body Diode)			I_S	-1	A
Lead Temperature for Soldering Purposes (1/8" from case for 10 sec)			T_L	260	$^\circ C$



5. Thermal resistance rating

Parameter	Symbol	Typ	Max	Units
Junction-to-Ambient – Steady State (Note 1)	$R_{\theta JA}$		260	°C/W
Junction-to-Ambient – $t \leq 10s$ (Note 1)	$R_{\theta JA}$		100	°C/W

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

1. Surface-mounted on FR4 board using 1 in sq pad size (Cu area = 1.127 in sq [2 oz] including traces)



6. Electrical Characteristics $T_J=25^\circ\text{C}$

Parameter	Symbol	Conditions	Min	Typ	Max	Units
Drain-to-Source Breakdown Voltage	$V_{(BR)DSS}$	$V_{GS}=0V, I_D=-250\mu A$	-30			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	$V_{(BR)DSS}/T_J$	$I_D=-250\mu A$ Referenced to 25°C		24		mV/ $^\circ\text{C}$
Zero Gate Voltage Drain Current	I_{DSS}	$V_{GS}=0V, V_{DS}=-24V, T_J=25^\circ\text{C}$			-1	μA
		$V_{GS}=0V, V_{DS}=-24V, T_J=85^\circ\text{C}$			-5	μA
Gate-to-Source Leakage Current	I_{GSS}	$V_{GS}=\pm 12V, V_{DS}=0V$			± 0.1	μA
ON CHARACTERISTICS (Note 3)						
Gate Threshold Voltage	$V_{GS(th)}$	$V_{DS}=V_{GS}, I_D=-250\mu A$	-0.7	-1.15	-1.4	V
Negative Threshold Temperature Coefficient	$V_{GS(th)}/T_J$			3.5		mV/ $^\circ\text{C}$
Drain-to-Source On-Resistance	$R_{DS(on)}$	$V_{GS}=-10V, I_D=-2.2A$		50	75	m Ω
		$V_{GS}=-4.5V, I_D=-1.8A$		60	110	
Forward Transconductance	g_{FS}	$V_{DS}=-5V, I_D=-2.2A$		7		S
CHARGES, CAPACITANCES AND GATE RESISTANCE						
Input Capacitance	C_{iss}	$V_{GS}=0V$		720		pF
Output Capacitance	C_{oss}	$f=1\text{MHz}$		95		pF
Reverse Transfer Capacitance	C_{rss}	$V_{DS}=15V$		65		pF
Total Gate Charge	$Q_{G(TOT)}$	$V_{GS}=-10V, V_{DS}=-15V$ $I_D=-3.5A$		15.6		nC
Threshold Gate Charge	$Q_{G(TH)}$			0.7		nC
Gate-to-Source Charge	Q_{gs}			1.6		nC
Gate-to-Drain Charge	Q_{gd}			2.6		nC
Total Gate Charge	$Q_{G(TOT)}$	$V_{GS}=-4.5V, V_{DS}=-15V$ $I_D=-3.5A$		7.4		nC
Threshold Gate Charge	$Q_{G(TH)}$			0.7		nC
Gate-to-Source Charge	Q_{gs}			1.6		nC
Gate-to-Drain Charge	Q_{gd}			2.6		nC
Gate Resistance	R_g			6.1		Ω



SWITCHING CHARACTERISTICS, $V_{GS}=4.5\text{ V}$ (Note 4)						
Turn-On Delay Time	$t_{D(on)}$	$V_{GS}=-10\text{V}, V_{DS}=-15\text{V}$ $I_D=-3.5\text{A}, R_g=6\Omega$		8		ns
Rise Time	t_r			11		ns
Turn-Off Delay Time	$t_{D(off)}$			32		ns
Fall Time	t_f			14		ns
Turn-On Delay Time	$t_{D(on)}$	$V_{GS}=-4.5\text{V}, V_{DS}=-15\text{V}$ $I_D=-3.5\text{A}, R_g=6\Omega$		9		ns
Rise Time	t_r			16		ns
Turn-Off Delay Time	$t_{D(off)}$			25		ns
Fall Time	t_f			22		ns
DRAIN-SOURCE DIODE CHARACTERISTICS						
Forward Diode Voltage	V_{SD}	$V_{GS}=0\text{V}, I_S=-1\text{A}, T_J=25^\circ\text{C}$		-0.8	-1.2	V
Reverse Recovery Time	t_{rr}	$V_{GS}=0\text{V}, I_S=-1\text{A}$ $d_{ISD}/d_t=100\text{ A}/\mu\text{s}$		14		ns
Charge Time	t_a			10		ns
Discharge Time	t_b			4		ns
Reverse Recovery Charge	Q_{rr}			8		nC

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

- Surface-mounted on FR4 board using 1 in sq pad size (Cu area = 1.127 in sq [2 oz] including traces).
- Pulse Test: Pulse Width $\leq 300\mu\text{s}$, Duty Cycle $\leq 2\%$.
- Switching characteristics are independent of operating junction temperatures.

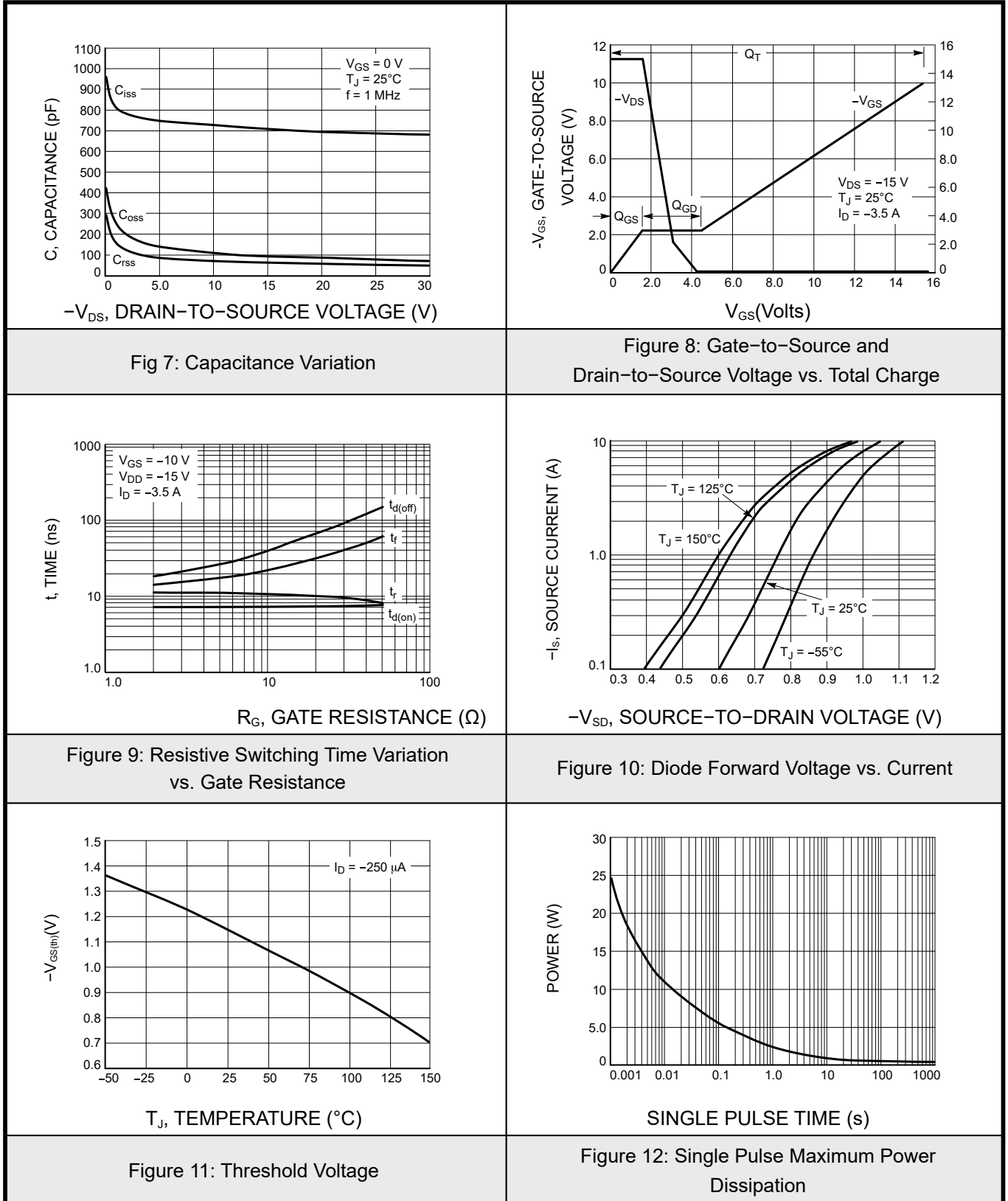


7.1 Typical Characteristics

<p>$-I_D$, DRAIN CURRENT (AMPS)</p> <p>$-V_{DS}$, DRAIN-TO-SOURCE VOLTAGE (V)</p>	<p>$-I_D$, DRAIN CURRENT (AMPS)</p> <p>$-V_{GS}$, GATE-TO-SOURCE VOLTAGE (V)</p>
<p>Fig 1: On-Region Characteristics</p>	<p>Figure 2: Transfer Characteristics</p>
<p>$R_{DS(on)}$, DRAIN-TO-SOURCE RESISTANCE (Ω)</p> <p>$-V_{GS}$, GATE VOLTAGE (V)</p>	<p>$R_{DS(on)}$, DRAIN-TO-SOURCE RESISTANCE (Ω)</p> <p>$-I_D$, DRAIN CURRENT (A)</p>
<p>Figure 3: On-Resistance vs. Gate-to-Source Voltage</p>	<p>Figure 4: On-Resistance vs. Drain Current and Gate Voltage</p>
<p>$R_{DS(on)}$, NORMALIZED DRAIN-TO-SOURCE RESISTANCE (Ω)</p> <p>T_J, JUNCTION TEMPERATURE ($^{\circ}C$)</p>	<p>I_{loss}, LEAKAGE (nA)</p> <p>$-V_{DS}$, DRAIN-TO-SOURCE VOLTAGE (V)</p>
<p>Figure 5: On-Resistance e Variation with Temperature</p>	<p>Figure 6: Drain-to-Source Leakage Current vs. Voltage</p>



7.2 Typical Characteristics





7.3 Typical Characteristics

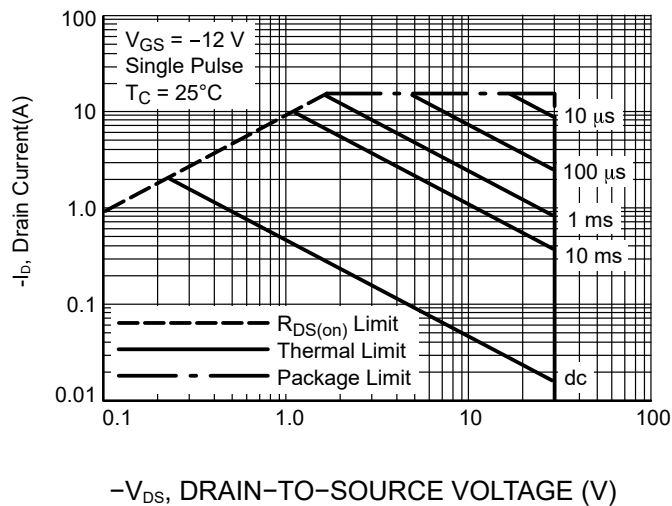


Figure 13. Maximum Rated Forward Biased Safe Operating Area

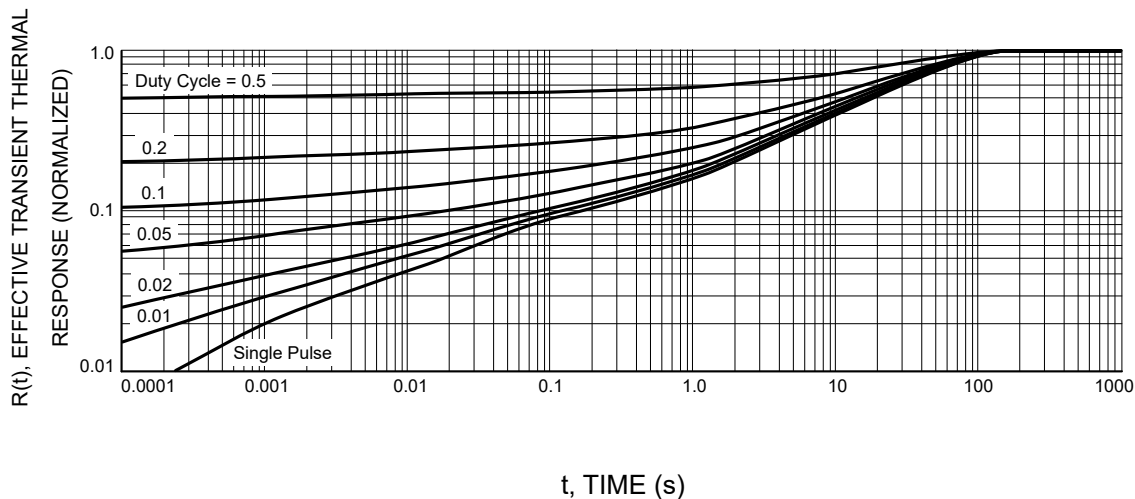
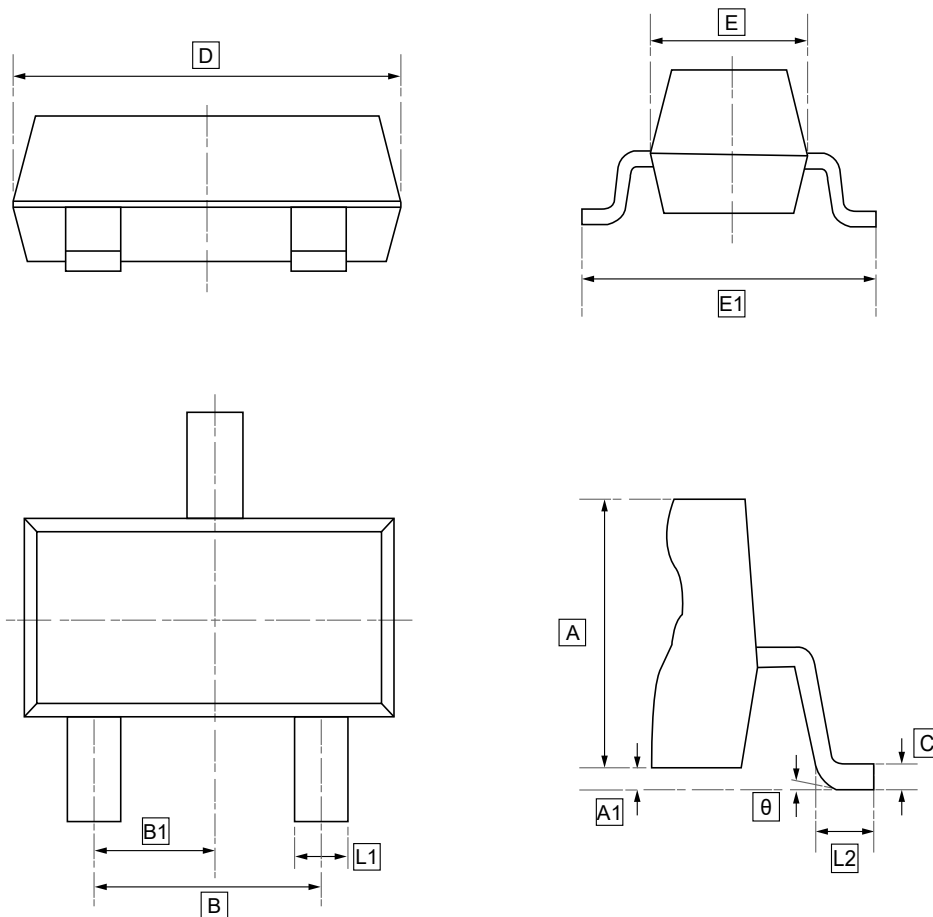


Figure 14. FET Thermal Response



8.SOT-23 Package Outline Dimensions

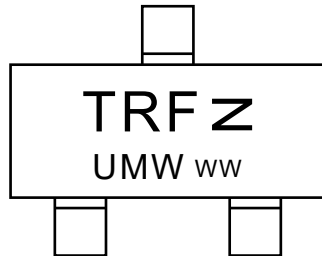


DIMENSIONS (mm are the original dimensions)

Symbol	A	A1	L1	L2	C	D	E	E1	B	B1	θ
Min	1.050	0.000	0.300	0.350	0.100	2.820	1.500	2.700	1.800	0.950	0°
Max	1.150	0.100	0.500	0.550	0.200	3.020	1.700	2.900	2.000	TYP	8°



9. Ordering information



WW: Batch Code

Order Code	Package	Base QTY	Delivery Mode
UMW NTR4171PT1G	SOT-23	3000	Tape and reel



10. Disclaimer

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